PCN Number:		202	20230816003.1						PCN Date:		December 06, 2023			
Title:	Qualification	of A	dditiona	al A	ssem	bly & Te	st	site optior	ns	for	select	: Dev	ices	
Customer	Contact:	Char	nge Mai	nage	emer	t team		Dept:	Q	ual	ity Se	rvice	s	
Proposed 1 st Ship Date:			Mar 5, 2024					Sample requests accepted until:			Jan 6, 2024*			
-	requests rec	eive	d after	' Jai	n 6, 2	2024 wil	l n	ot be su	pp	ort	ed.			
Change Type:														
	bly Site					sign	gn				Wafer Bump Material			
	bly Process					ta Sheet					Wafer Bump Process			
Assembly Materials							number change				Wafer Fab Site			
Mechanical Specification						st Site	st Site				Wafer Fab Material			
📙 Packin	Packing/Shipping/Labeling 🔲 Test Process 🗌 Wafer Fab Process				S									
					P	CN Det	ai	ls						
Descriptio	on of Change	21												
for Select	ruments is ple Devices listed ion differen e	in th	e "Proc	luct	: Affe				IX a	as i	an ado	dition	al Asse	mbly Site
						ASESH				FM)	X]		
	Mount Compound					EY1000063			4	1478	358			
	Mold Compound				SII	D#EN2000506			4	2118	380			
	Lead finish					Matte Sn NiPdAu		Au]					
	Bond wire composition, diameter					r	Aι	Au, 1.0 mil Cu, 0.96 mil		6 mil]			

Upon expiry of this PCN TI will combine lead free solutions in a single <u>standard part number</u>. For example; <u>MUX508ID</u> – can ship with both Matte Sn and NiPdAu.

Example:

 Customer order for 7500 units of MUX508ID with 2500 units SPQ (Standard Pack Quantity per Reel).

– TI can satisfy the above order in one of the following ways.

- I. 3 Reels of NiPdAu finish.
- II. 3 Reels of Matte Sn finish
- III. 2 Reels of Matte Sn and 1 reel of NiPdAu finish.
- IV. 2 Reels of NiPdAu and 1 reel of Matte Sn finish.

Reason for Change:

Continuity of supply.

Enable additional A/T capacity to support high volume ramps.

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

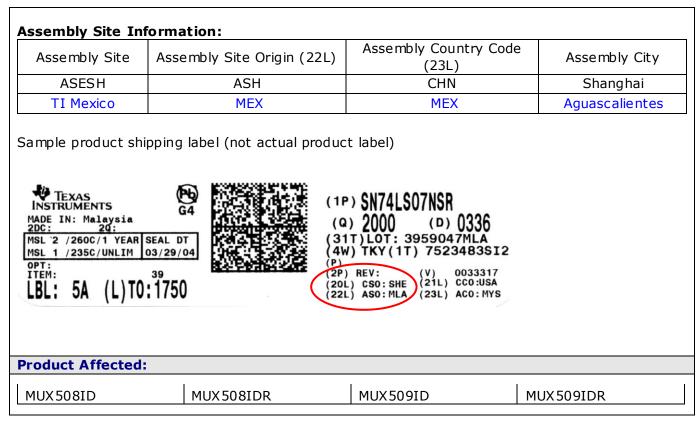
None

Impact on Environmental Ratings

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
🛛 No Change	🛛 No Change	🛛 No Change	🛛 No Change

Changes to product identification resulting from this PCN:



TEXAS INSTRUMENTS

TI Information Selective Disclosure

Qualification Report

Add FMX as Second Source Assembly Site for TMUX508 & TMUX509 SOIC Devices with BOM: NIPDAU LF/QMI-505MT/CU WIRE/EME-G633C Approve Date: 27 January 2023

Product Attributes

Attributes	QBS Device: ADS1131IDR	QBS Device: OPA2313QDRQ1	QBS Device: TLC5973DR	QBS Device: TL494IDR
Assembly Site	FMX	FMX	FMX	FMX
Pin Count	16	8	8	16
Package Designator	D	D	D	D
Wafer Fab Supplier	DP1DM5	AIZU	MH8	SH-BIP-1
Wafer Process	50HPA07	50HPA07	LBC7	JI1
Flammability Rating	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0

Qual Device ADS1131IDR is qualified at MSL2-260C

Qual Device OPA2313QDRQ1 is qualified at MSL2-260C Qual Device TLC5973DR is qualified at MSL1-260C

Qual Device TLC5973DR is qualified at MSL1-2600
Qual Device TL494IDR is qualified at MSL1-260C

Qualification Results							
Data Displayed as: Number of lots / Total sample size / Total failed							

Туре	Test Name / Condition	Duration	QBS Device: ADS1131IDR	QBS Device: OPA2313QDRQ1	QBS Device: TLC5973DR	QBS Device: TL494IDR
PC	Preconditioning	Level 1 - 260C			3/924/0	3/1155/0
PC	Preconditioning	Level 2 - 260C	3/693/0	3/865/0		
AC	Autoclave, 121C	96 Hours	3/231/0	3/231/0	3/231/0	3/231/0
BHAST	Biased HAST, 130C	96 Hours		3/231/0	3/231/0	3/231/0
CHAR	Electrical Characterization	Per datasheet		Pass	Pass	Pass
HTOL	Life Test, 150C	300 Hours				3/231/0
HTOL	Life Test, 125C	1000 Hours		3/231/0	1/77/0	
HTSL	High Temp Storage Bake, 170C	600 Hours	3/231/0	1/45/0		3/231/0
HTSL	High Temp Storage Bake, 150C	1000 Hours			3/231/0	
MQ	Manufacturability (Assembly)	Per mfg. site spec	Pass	Pass	Pass	Pass
MSL	Moisture Sensitivity	Level 1-260C	3/36/0	3/36/0	3/36/0	3/36/0
тс	Temperature Cycle, -65C/150C	500 Cycles	3/231/0	3/231/0	3/231/0	3/231/0
TS	Thermal Shock, -65C/150C	500 Cycles				3/231/0
SD	Solderability, Pb-Free	Steam Age Precon		1/15/0		3/66/0
SD	Solderability, Pb	Steam Age Precon		1/15/0	3/66/0	3/66/0
DSS	Die Shear Strength	Die	3/30/0	3/30/0	3/30/0	3/30/0
WBP	Wire Bond Pull	Wires	3/228/0	3/184/0	3/228/0	3/228/0
LP	Lead Pull	Leads	3/66/0			3/66/0
VM	Visual Mechanical	Per mfg. site spec			Pass	Pass
XR	Internal X-Ray	Top Down			3/15/0	3/15/0
FL	Flammability	IEC 695-2-2				3/15/0
FL	Flammability	UL 94V-0				3/15/0
FL	Flammability	UL-1694				3/15/0

Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1000 Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1000 Hours, and 170C/420 Hours

The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1000 Hours, and 1/0C/420 Ho
The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

For questions regarding this notice, e-mails can be sent to the Change Management team or your local Field Sales Representative.

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